

## **Search Notes**



**Application/Control No.**

10/748,062

Examiner

Ellen C. Tran

**Applicant(s)/Patent under  
Reexamination**

CROMER ET AL.

Art Unit

2134

**SEARCHED**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, DERWENT, IBM TECH DES	6/7/2007	ECT
NPL - IEEE XPLORER	6/7/2007	ECT
INVENTOR SEARCH - PALM	6/7/2007	ECT
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTIONS	6/7/2007	ECT